

Product Name: Tablet	Report No: ITEZA202300349RF7
Product Model: T30 Max, T30 Max Cypher, T30 Max Flash, T30 Max Fire, T30 Max Storm, T30 Max Elite, T30 Max Nova	Security Classification: Open
Version: V1.0	Total Page: 57

TIRT Testing Report

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RF TEST REPORT

FCC ID: 2AX4YT30MAX

According to

FCC CFR Title 47 Part 2 FCC CFR Title 47 Part 22 Subpart H FCC CFR Title 47 Part 24 Subpart E FCC CFR Title 47 Part 27 Subpart C FCC CFR Title 47 Part 90 Subpart S ANSI C63.26:2015 KDB 971168 D01 Power Meas License Digital Systems v03r01

Applicant:	Shenzhen DOOGEE Hengtong Technology CO.,LTD
Address:	B, 2/F, Building A4, Silicon Valley Power Digital Industrial Park, No. 22, Longhua New District, Shenzhen, China
Manufacturer:	Shenzhen DOOGEE Hengtong Technology CO.,LTD
Address:	B, 2/F, Building A4, Silicon Valley Power Digital Industrial Park, No. 22, Longhua New District, Shenzhen, China
Sample No:	1000029923
Product Name:	Tablet
Brand Name:	DOOGEE
Model No.:	T30 Max, T30 Max Cypher, T30 Max Flash, T30 Max Fire, T30 Max Storm, T30 Max Elite, T30 Max Nova
Test No.:	T30 Max

Date of Receipt:	2024/03/20
Date of Test:	2024/03/20~2024/04/01
Issued Date:	2024/04/08
Testing Lab:	TIRT

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History of this test report Original Report Issue Date: 2024.04.08

- No additional attachment
- Additional attachments were issued following record

Attachment No.	Issue Date	Description



1 TEST SUMMARY		
Test Item	Section in CFR 47	Result
	Part 1.1307	Pass*(Please refer to
RF Exposure (SAR)	Part 2.1093	SAR Report)
	Part 2.1046	
	Part 22.913(a)	
	Part 24.232(b)	
RF Output Power	Part 27.50(b)	Pass
	Part 27.50(c)	F d S S
	Part 27.50(d)	
	Part 27.50(h)	
	Part 90.635	
	Part 2.1046	
Book To Average Batio	Part 22.913(d)	Deep
Peak-To-Average Ratio	Part 24.232 (d)	Pass
	Part 27.50(d)	
Modulation Characteristics	Part 2.1047	N/A
	Part 2.1049	
00% & 20 dD Occurried Denduidth	Part 22.917	Deen
99% & -26 dB Occupied Bandwidth	Part 24.238	Pass
	Part 27.53(a)	
	Part 2.1051	
	Part 22.917	
	Part 24.238	
Spurious Emissions at Antenna Terminal	Part 27.53(c)(f)	Pass
Spurious Emissions at Antenna Terminar	Part 27.53(g)	F d S S
	Part 27.53(h)	
	Part 27.53(m)	
	Part 90.691	
	Part 2.1053	
	Part 22.917	
	Part 24.238	
Field Strength of Spurious Radiation	Part 27.53(c)(f)	Pass
	Part 27.53(g)	1 000
	Part 27.53(h)	
	Part 27.53(m)	
	Part 90.691	



	Part 2.1051	
	Part 22.917	
	Part 24.238	
Out of hand emission Dand Edge	Part 27.53(c)(f)	Deee
Out of band emission, Band Edge	Part 27.53(g)	Pass
	Part 27.53(h)	
	Part 27.53(m)	
	Part 90.691	
	Part 2.1055(a)(1)(b)	
	Part 22.355	
Frequency stability vs. temperature	Part 24.235	Pass
	Part 27.54	
	Part 90.213	
	Part 2.1055(d)(1)(2)	
	Part 22.355	
Frequency stability vs. voltage	Part 24.235	Pass
	Part 27.54	
	Part 90.213	

Note: 1. Pass: The EUT complies with the essential requirements in the standard.

2. The conclusion of this test report is judged by actual test data without considering measurement uncertainty.



2 GENERAL INFORMATION

2.1 GENERAL DESCRIPTION OF EUT

Description of Device (EU		
EUT Name	Tablet	
Model No.	T30 Max, T30 Max Cypher, T30 Max Flash, T30 Max Fire, T30 Max Storn T30 Max Elite, T30 Max Nova	١,
DIFF.	There is no difference except the name of the model. All tests are made w	vith
	the T30 Max model.	
Power supply	DC 3.8V from battery or DC11V from adapter	
Support Bands	LTE Band 2/4/5/7/12/17/25/26/38/40/41/66	
Channel Bandwidth	LTE Band 2: 1.4MHz, 3MHz, 5MHz, 10MHz, 15MHz, 20MHz LTE Band 4: 1.4MHz, 3MHz, 5MHz, 10MHz, 15MHz, 20MHz LTE Band 5: 1.4MHz, 3MHz, 5MHz, 10MHz LTE Band 7: 5MHz, 10MHz, 15MHz, 20MHz LTE Band 12: 1.4MHz, 3MHz, 5MHz, 10MHz LTE Band 17: 5MHz, 10MHz LTE Band 25: 1.4MHz, 3MHz, 5MHz, 10MHz, 15MHz, 20MHz LTE Band 26: 1.4MHz, 3MHz, 5MHz, 10MHz LTE Band 26: 1.4MHz, 3MHz, 5MHz, 10MHz LTE Band 38: 5MHz, 10MHz, 15MHz, 20MHz LTE Band 38: 5MHz, 10MHz, 15MHz, 20MHz LTE Band 66: 1.4MHz, 3MHz, 5MHz, 10MHz, 15MHz, 20MHz LTE Band 5: 824 ~ 849 MHz LTE Band 5: 824 ~ 849 MHz LTE Band 7: 2500 ~2570 MHz LTE Band 12: 699MHz ~ 716 MHz LTE Band 25: 1850 MHz ~ 1915 MHz LTE Band 26: 814 MHz ~ 849 MHz LTE Band 26: 814 MHz ~ 849 MHz LTE Band 38: 2570 MHz ~ 2620 MHz LTE Band 41: 2496MHz ~ 2670MHz LTE Band 66: 1710 MHz ~ 1780 MHz DEDEM	
Modulation type	QPSK, 16QAM	
Antenna Type	Internal antenna, LTE Band 2: Maximum Gain is 0.25dBi.	
	LTE Band 4: Maximum Gain is 0.3dBi. LTE Band 5: Maximum Gain is -2.1dBi. LTE Band 7: Maximum Gain is 0.8dBi. LTE Band 12: Maximum Gain is -2.3dBi. LTE Band 17: Maximum Gain is -2.3dBi. LTE Band 25: Maximum Gain is 0.25dBi. LTE Band 26: Maximum Gain is 0.25dBi. LTE Band 38: Maximum Gain is 0.8dBi. LTE Band 38: Maximum Gain is 0.8dBi. LTE Band 66: Maximum Gain is 0.3dBi. Antenna information is provided by applicant. There is WWAN diversity antenna inside the product, which is only for receiving function.	



Software version : DOOGEE-T30 Max-EEA-Android14.0-20240318 Hardware version : P3T_TV1.0_20240120

Remark 1: The worst-case simultaneous transmission configuration was evaluated with no non-compliance found. Results in this report are only for 4G function, and there is no other transmitter involved.



2.2 RELATED SUBMITTAL(S) / GRANT (S)

This submittal(s) (test report) is filing to comply with Section Part 22 subpart H and Part 24 subpart E of the FCC CFR 47 Rules.

2.3 TEST FACILITY

Company:	Beijing TIRT Technology Service Co.,Ltd Shenzhen
Address:	104 Building C, Xinmingsheng Industrial Park No.132, Zhangge Old Village East Zone, Zhangge Community, Fucheng Street, Longhua District, Shenzhen, Guangdong, P. R. China
CNAS Registration Number:	CNAS L14158
A2LA Registration Number:	6049.01
FCC Accredited Lab.Designation Number:	CN1366
FCC Test Firm Registration Number:	820690
Telephone:	+86-0755-27087573

2.4 ACCESSORIES OF DEVICE (EUT)

Accessories	Adapter
Manufacturer	/
Model	TP303C-US
	Input: AC100-240V~ 50/60Hz 0.7A Max
	Output: USB-C:5.0V=3.0A, 15.0W, 9.0V=3.0A, 27.0W,
Ratings	12.0V=2.5A,30.0W, 15.0V=2.0A, 30.0W, 20.0V=1.5A,
-	30.0W,
	PPS:5.0V-11.0V=3.0A 33.0W
	Power: 33.0W

2.5 TESTED SUPPORTING SYSTEM DETAILS

No.	Description	Manufacturer	Model	Serial Number	Certification or SDoC
1	N/A	N/A	N/A	N/A	N/A

2.6 TEST CONDITIONS

Items	Required	Actual
Temperature range:	15-35℃	24°C
Humidity range:	25-75%	56%
Pressure range:	86-106kPa	98kPa



2.7 MEASUREMENT UNCERTAINTY

Uncertainty				
Parameter	Uncertainty			
Occupied Channel Bandwidth	±142.12 KHz			
RF power conducted	±0.74 dB			
RF power radiated	±3.25dB			
Spurious emissions, conducted	±1.78dB			
Spurious emissions, radiated (9KHz~30MHz)	±2.56dB			
Spurious emissions, radiated (30MHz \sim 1GHz)	±4.6dB			
Spurious emissions, radiated (Above 1GHz)	±4.9dB			
Conduction Emissions(150kHz~30MHz)	±3.1 dB			
Humidity	±4.6%			
Temperature	±0.7°C			
Time	±1.25%			



3 TEST INSTRUMENTS LIST

Name of Emvironment Manufactures Madel Number Cariel Number Last Due						
Name of Equipment	Manufacturer	Model Number	Serial Number	Calibration	Calibration	
EMI Receiver	Rohde&Schwarz	ESIB 40	YH-TIRT-SAC-966 -20220911	2024/01/05	2025/01/04	
Integral Antenna	Schwarzbeck	VULB 9163	01314	2022.12.11	2024.12.10	
Integral Antenna	Rohde&Schwarz	HF907	RSM2991424	2022.12.11	2024.12.10	
Preamplifier	Emtrace	RP01A	'02017	2024/01/05	2025/01/04	
Preamplifier	Schwarzbeck	BBV9744	00143	2024/01/05	2025/01/04	
Loop Antenna	ZHINAN	ZN30900A	12024	2024/01/05	2025/01/04	
Exposure Level Tester	narda	ELT-400	N-0925	2024/01/05	2025/01/04	
Horn Antenna	Schwarzbeck	BBHA9170	00956	2024/01/05	2025/01/04	
RF Cable	/	LMR400UF-NMNM-7. 0M	/	2024/01/05	2025/01/04	
RF Cable	/	SFT2050PUR-NMNM -7.0M	/	2024/01/05	2025/01/04	
EMI Receiver	Rohde&Schwarz	ESR7	1316.3003K07-10 2611-mk	2023/11/02	2024/11/01	
LISN	Rohde&Schwarz	ENV216	3560.655.12-1029 15-Bp	2023/11/02	2024/11/01	
ISN	Schwarzbeck	ENY81	1309.8510.03	2024/01/05	2025/01/04	
ISN	Schwarzbeck	ENY81-CAT6	1309.8526.03-101 976-kh	2024/01/05	2025/01/04	
RF Cable	١	SFT2050PUR-NMNM -2.0M	\	2024/01/05	2025/01/04	
CMW500	ROHDE&SCHWARZ	CMW500	120434	2024/01/05	2025/01/04	
Spectrum analyzer	ROHDE&SCHWARZ	FSU26	200732	2024/01/05	2025/01/04	
Spectrum analyzer	ROHDE&SCHWARZ	FSV40-N	101722	2024/01/05	2025/01/04	
vector Signal Generator	KEYSIGHT	N5182B	MY56200458	2024/01/05	2025/01/04	
vector Signal Generator	HEWLETT PACKARD	83752A	3610A02458	2024/01/05	2025/01/04	
Filter	HEWLETT PACKARD	JS0806-F	19K8060209	2024/01/05	2025/01/04	
Wireless comprehensive tester	ANRISTU	MT8821C	SN6262170409	2024/01/05	2025/01/04	
Wireless comprehensive tester	ANRISTU	MT8000A	SN6262166782	2024/01/05	2025/01/04	



4 SYSTEM TEST CONFIGURATION

4.1 TEST MODE

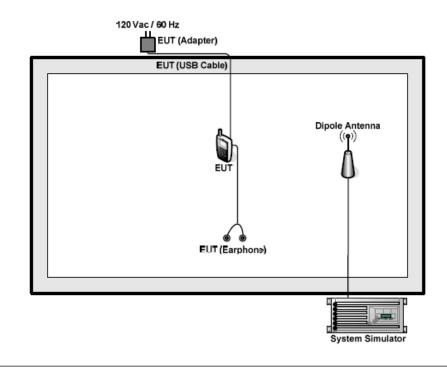
During all testing, EUT is in link mode with base station emulator at maximum power level. The spurious emission measurements were carried out in semi-anechoic chamber with 3-meter test range, and EUT is rotated on three test planes to find out the worst emission.

Test modes					
Band	Radiated	Conducted			
LTE Band 2	QPSK link, 16QAM link	QPSK link, 16QAM link			
LTE Band 4	QPSK link, 16QAM link	QPSK link, 16QAM link			
LTE Band 5	QPSK link, 16QAM link	QPSK link, 16QAM link			
LTE Band 7	QPSK link, 16QAM link	QPSK link, 16QAM link			
LTE Band 12	QPSK link, 16QAM link	QPSK link, 16QAM link			
LTE Band 17	QPSK link, 16QAM link	QPSK link, 16QAM link			
LTE Band 25	QPSK link, 16QAM link	QPSK link, 16QAM link			
LTE Band 26	QPSK link, 16QAM link	QPSK link, 16QAM link			
LTE Band 38	QPSK link, 16QAM link	QPSK link, 16QAM link			
LTE Band 41	QPSK link, 16QAM link	QPSK link, 16QAM link			
LTE Band 66	QPSK link, 16QAM link	QPSK link, 16QAM link			

Note: Antenna port conducted and radiated test items were performed according to KDB 971168 D01 Power Meas License Digital Systems v03r1 with maximum output power.

Radiated measurements were performed with rotating EUT in different three orthogonal test planes to find the maximum emission.

4.2 CONFIGURATION OF TESTED SYSTEM





Test Requirement:	Part 2.1046,Part 22.913(a), Part 24.232(c), Part 27.50(b), Part 27.50(c), Part 27.50(d), Part 27.50(h), Part 90.635			
Test Method:	ANSI C63.26:2015			
Limit:	LTE Band 2: 2W			
	LTE Band 4: 1W			
	LTE Band 5: 7W			
	LTE Band 7: 2W			
	LTE Band 12: 3W			
	LTE Band 17: 3W			
	LTE Band 25: 2W			
	LTE Band 26: 100W			
	LTE Band 38: 2W			
	LTE Band 41: 2W			
	LTE Band 66: 1W			
Test setup:	EUT Splitter Tester			
	Power meter			
	Fowermeter			
	Note: Measurement setup for testing on Antenna connector			
Test Procedure:	1. The transmitter output port was connected to base station.			
	2. The RF output of EUT was connected to the power meter by RF			
	cable and attenuator, the path loss was compensated to the resufine for each measurement.			
	3. Set EUT at maximum power through base station.			
	4. Select lowest, middle, and highest channels for each band and			
	different modulation.			
	5. Measure the maximum burst average power.			
Test Instruments:	Refer to section 3 for details			
Test mode:	Refer to section 4.1 for details			
Test results:	Pass			



Test Requirement:	Part 22.913(d), FCC part24.232(d) and FCC part27.50(d)(5)		
Test Method:	ANSI C63.26:2015		
Test Limit:	Used complementary cumulative distribution function (CCDF) of		
	analyzer to determine that PAPR will not exceed 13 dB for more than		
	0.1 percent of the time		
Test setup:	EUT Splitter Communication Tester		
	Note: Measurement setup for testing on Antenna connector		
Test Procedure:	1. The testing follows FCC KDB 971168 D01 v03r01 Section 5.7		
	2. The EUT was connected to spectrum and system simulator via a power divider		
	3. Using the CCDF measurement ofspectrum analyzer;		
	4. Set RBW≥OBW or specified reference bandwidth;		
	5. Set the number of counts to a value that stabilizes the measured CCDF curve;		
	6. Set the measurement interval as 1ms		
	 Record the maximum PAPR level associated with a probability of 0.1%. 		
Test Instruments:	Refer to section 3 for details		
Test mode:	Refer to section 4.1 for details		
Test results:	Pass		

Note: Please refer to Appendix B of the Appendix Test Data.



4.5 OCCUPY BANDWIDTH FCC part22.913(a), FCC part24.232(b) and FCC part27.53(a), FCC part **Test Requirement:** 90.209 ANSI C63.26:2015 Test Method: Test setup: Communication Splitter EUT Tester SPA Note: Measurement setup for testing on Antenna connector 1. The EUT's output RF connector was connected with a short cable to **Test Procedure:** the spectrum analyzer, set center frequency to channel center frequency. 2.RBW was set to about 1%-5% of emission OBW, VBW≥ 3 X RBW. 3.Set spectrum analyzer detection mode to peak, and the trace mode to max hold. 4. Use the 99% OBW function, The 99% power OBW can be found on the plot, determine the "-26dB amplitude" as equal to reference value -26dB. Refer to section 3 for details Test Instruments: Refer to section 4.1 for details Test mode: Pass Test results:

Note: Please refer to Appendix C of the Appendix Test Data.



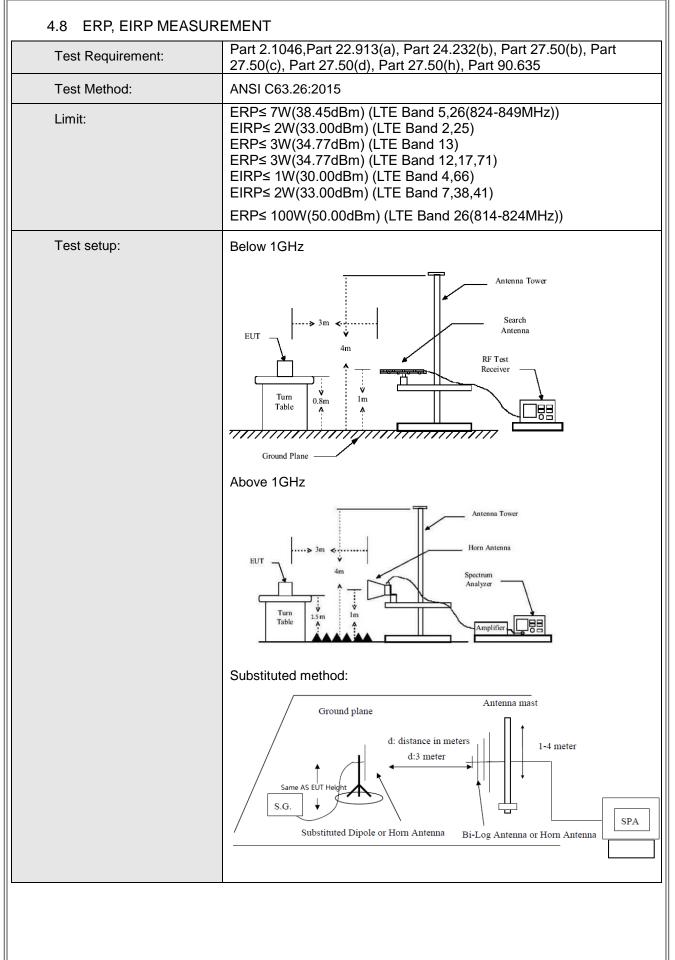
4.6 MODULATION CHARACTERISTIC

According to FCC § 2.1047(d), Part 24E & Part 27 there is no specific requirement for digital modulation, therefore modulation characteristic is not presented.



Test Requirement:	Part 2.1051 Part 22.917 Part 24.238 Part 27.53(c)(f) Part 27.53(g) Part 27.53(h) Part 27.53(m) Part 90.691		
Test Method:	ANSI C63.26:2015		
Limit:	 ≤ -13dBm(LTE Band5,26(824-849MHz)) ≤ -13dBm(LTE Band2,25) ≤ -13dBm(LTE Band12, 17, 71) ≤ -13dBm(LTE Band4,66) ≤ -25dBm(LTE Band 7, 38, 41) ≤ -13dBm(LTE Band26(814-824MHz)) 		
Test setup:	EUT Splitter Communication Tester Filter SPA		
	Note: Measurement setup for testing on Antenna connector		
Test Procedure:	 The RF output of the transceiver was connected to a spectrum analyzer through appropriate attenuation. The resolution bandwidth of the spectrum analyzer was set at 1MHz, sufficient scans were taken to show the out of band Emissions if any up to 10th harmonic. For the out of band: Set the RBW=1MHz, VBW = 3MHz, Start=30MHz, Stop= 10th harmonic. Band Edge Requirements: In the 1 MHz bands immediately outside and adjacent to the frequency block, a resolution bandwidth of at least 1 percent of the emission bandwidth of the fundamental emission of the transmitter may be employed to measure the out of band Emissions. 		
Test Instruments:	Refer to section 3 for details		
Test mode:	Refer to section 4.1 for details		
Test results:	Pass		

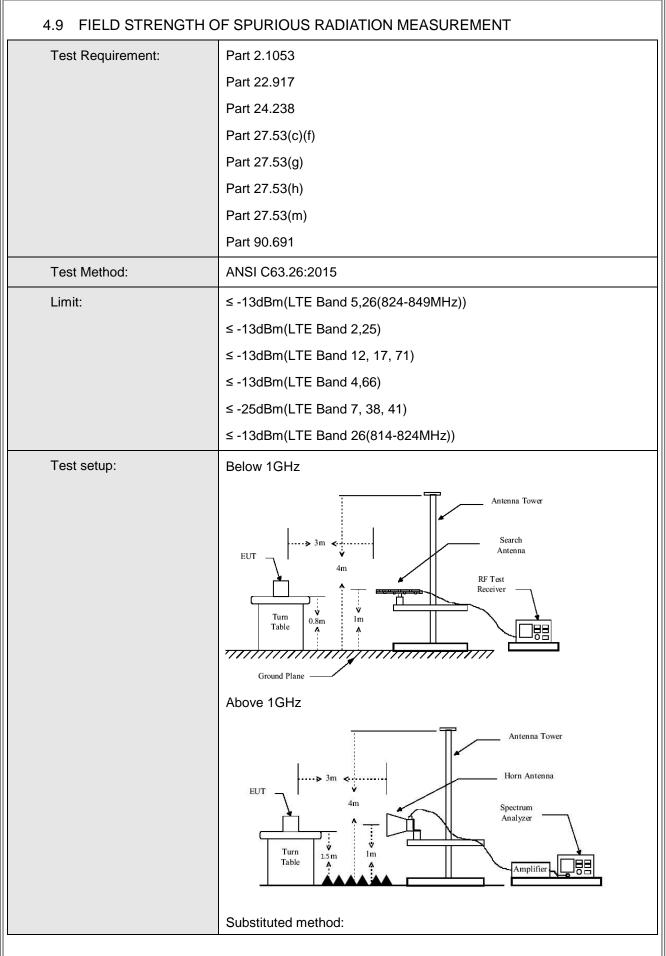






Test Procedure:	1. The EUT was placed on an non-conductive turntable using a
	non-conductive support. The radiated emission at the fundamental
	frequency was measured at 3 m with a test antenna and EMI
	spectrum analyzer.
	2. During the measurement, the EUT was communication with the
	station. The highest emission was recorded with the rotation of the
	turntable and the lowering of the test antenna from 4m to 1m. The
	reading was recorded and the field strength (E in dBuV/m) was
	calculated.
	3. ERP were measured using a substitution method. The EUT was
	replaced by dipole antenna connected, the S.G. output was
	recorded and ERP was calculated asfollows:
	ERP = S.G. output (dBm) + Antenna Gain (dBd) – Cable Loss (dB)
	4. EIRP were measured using a substitution method. The EUTwas
	replaced by or horn antenna connected, the S.G. output was
	recorded and EIRP was calculated asfollows:
	EIRP = S.G. output (dBm) + Antenna Gain (dBi) – Cable Loss (dB)
Test Instruments:	Refer to section 3 for details
Test mode:	Refer to section 4.1 for details
Test results:	Pass
Remark:	H,E1,E2 mean for EUT polarization of X, Y, Z
Note: Please refer to Appendi	x A of the Appendix Test Data.







F

Report No.:ITEZA202300349RF3

1

	Ground plane Ground plane d: distance in meters d: distance in meters Same AS EUT Height S.G. Substituted Dipole or Hom Antenna Bi-Log Antenna or Hom Antenna
Test Procedure:	 The EUT was placed on an non-conductive turntable using a non-conductive support. The radiated emission at the fundamental frequency was measured at 3 m with a test antenna and EMI spectrum analyzer.
	 During the tests, the antenna height and the EUT azimuth were varied in order to identify the maximum level of emissions from the EUT. This maximization process was repeated with the EUT positioned in each of its three orthogonal orientations.
	3. The frequency range up to tenth harmonic was investigated for each of three fundamental frequency(low, middle and high channels). Once spurious emission was identified, the power of the emission was determined using the substitution method.
	 The spurious emissions attenuation was calculated as the difference between radiated power at the fundamental frequency and the spurious emissions frequency. ERP / EIRP = S.G. output (dBm) + Antenna Gain(dB/dBi) – Cable Loss (dB)
Test Instruments:	Refer to section 3 for details
Test mode:	Refer to section 4.1 for details
Test results:	Pass



Measurement Data:

QPSK Mode:

QPSK Mode:		0/4 4841-	Testal		
Test mode:	LTE Band 2(1.4MHz)		Test channel:	Lowest	
Frequency (MHz)	Spurious Polarization	Emission Level (dBm)	Limit (dBm)	Result	
3701.24	Vertical	-35.25			
5552.24	V	-38.69	_	Dees	
7402.56	V	-38.69 -37.03	-13.00		
	V V		-13.00	Pass	
9253.35	V	-40.25	-		
11104.54	-				
3701.38	Horizontal	-39.02	-		
5552.28	H	-42.25	40.00	Dees	
7402.78	H	-43.21	-13.00	Pass	
9253.42	H	-45.01	_		
11104.36	H				
Test mode:		2(1.4MHz)	Test channel:	Middle	
Frequency (MHz)		Emission	Limit (dBm)	Result	
,	Polarization	Level (dBm)	, ,		
3760.00	Vertical	-36.25	_	Pass	
5640.00	V	-38.28	-13.00		
7520.00	V	-38.23			
9400.00	V	-43.31	4		
11280.00	V				
3760.00	Horizontal	-38.35	_	Pass	
5640.00	Н	-42.12	_		
7520.00	Н	-44.25	-13.00		
9400.00	Н	-45.01			
11280.00	Н				
Test mode:	LTE Band	2(1.4MHz)	Test channel:	Highest	
Frequency (MHz)	•	Emission	Limit (dBm)	Result	
	Polarization	Level (dBm)		Robuit	
3818.60	Vertical	-37.36	_	Pass	
5727.90	V	-39.12	4		
7637.20	V	-37.64	-13.00		
9546.50	V	-42.35	_		
11455.80	V				
3818.60	Horizontal	-38.10			
5727.90	Н	-42.38			
7637.20	Н	-43.24	-13.00	Pass	
9546.50	Н	-44.31			
11455.80	Н				

Remark :

1. The emission behaviour belongs to narrowband spurious emission, all modes investigated and only worst case is reported.

2. Remark"----" means that the emission level is too low (20dB lower than the limit) to be measured

3. The emission levels of below 1 GHz are very lower (20dB lower than the limit) than the limit and not show in test report.



Test mode:	LTE Band 4(1.4MHz)		Test channel:	Lowest
Frequency (MHz)	Spurious Polarization	Emission Level (dBm)	Limit (dBm)	Result
3421.40	Vertical	-38.31		
5132.10	Venical	-39.12	-	
6842.80	V	-37.35	-13.00	Pass
8553.50	V	-43.31	-13.00	F d 55
10264.20	V	-45.51	-	
3421.40	Horizontal	-38.61		
5132.10	H	-41.35		
6842.80	H	-41.35	12.00	Pass
			-13.00	Pass
8553.50	<u>H</u>	-44.35	_	
10264.20	H		-	
Test mode:		4(1.4MHz)	Test channel:	Middle
Frequency (MHz)	· · · · · · · · · · · · · · · · · · ·	Emission	Limit (dBm)	Result
	Polarization	Level (dBm)	, , ,	
3465.00	Vertical	-35.67	_	Pass
5197.50	V	-38.31	_	
6930.00	V	-36.35	-13.00	
8662.50	V	-43.12		
10395.00	V			
3465.00	Horizontal	-37.56		
5197.50	Н	-41.35		
6930.00	Н	-44.65	-13.00	Pass
8662.50	Н	-45.64		
10395.00	Н			
Test mode:	LTE Band	4(1.4MHz)	Test channel:	Highest
Frequency (MHz)	Spurious	Emission	Limit (dBm)	Result
Frequency (MHZ)	Polarization	Level (dBm)		Result
3508.60	Vertical	-35.64		
5262.90	V	-38.61		
7017.20	V	-37.02	-13.00	Pass
8771.50	V	-41.55]	
10525.80	V]	
3508.60	Horizontal	-38.61		
5262.90	Н	-42.31	1	
7017.20	Н	-43.27	-13.00	Pass
8771.50	H	-45.03		
10525.80	H		1	
Pomark.		1		

1. The emission behaviour belongs to narrowband spurious emission, all modes investigated and only worst case is reported.

2. Remark"---" means that the emission level is too low (20dB lower than the limit) to be measured

3. The emission levels of below 1 GHz are very lower (20dB lower than the limit) than the limit and not show in test report.



Test mode:	LTE Band	5(1.4MHz)	Test channel:	Lowest
		Emission		
Frequency (MHz)	Polarization	Level (dBm)	– Limit (dBm)	Result
1649.40	Vertical	-36.54		
2474.10	V	-39.01	-13.00	
3298.80	V	-37.31		Pass
4123.50	V	-42.63		
4948.20	V			
1649.40	Horizontal	-37.62		
2474.10	Н	-41.31		
3298.80	Н	-43.54	-13.00	Pass
4123.50	Н	-42.61		
4948.20	Н			
Test mode:	LTE Band	l 5(1.4MHz)	Test channel:	Middle
Frequency (MHz)	Spurious	Emission	Limit (dBm)	Result
Frequency (MHZ)	Polarization	Level (dBm)		Result
1673.00	Vertical	-35.30		
2509.50	V	-38.61		
3346.00	V	-37.35	-13.00	Pass
4182.50	V	-42.31		
5019.00	V			
1673.00	Horizontal	-37.35		
2509.50	Н	-41.58		Pass
3346.00	Н	-43.54	-13.00	
4182.50	Н	-45.28		
5019.00	Н			
Test mode:	LTE Band	5(1.4MHz)	Test channel:	Highest
Frequency (MHz)		Emission	Limit (dBm)	Result
	Polarization	Level (dBm)		Roourt
1696.60	Vertical	-37.13	_	
2544.90	V	-38.35		
3393.20	V	-37.35	-13.00	Pass
4241.50	V	-43.12	4	
5089.80	V			
1696.60	Horizontal	-38.51		
2544.90	Н	-42.12		
3393.20	Н	-44.32	-13.00	Pass
4241.50	Н	-45.31		
5089.80	Н			

1. The emission behaviour belongs to narrowband spurious emission, all modes investigated and only worst case is reported.

- 2. Remark"---" means that the emission level is too low (20dB lower than the limit) to be measured
- 3. The emission levels of below 1 GHz are very lower (20dB lower than the limit) than the limit and not show in test report.



			· · · · · · · · · · · · · · · · · · ·	
Test mode:	LTE Ban	d 7(5MHz)	Test channel:	Lowest
Fraguanov (MHz)	Spurious	Emission	Limit (dPm)	Result
Frequency (MHz)	Polarization	Level (dBm)	Limit (dBm)	Result
5040.14	Vertical	-35.35		
7868.14	V	-37.31		
10028.31	V	-36.58	-25.00	Pass
12535.12	V	-42.61		
15028.61	V			
5040.14	Horizontal	-37.31		
7868.14	Н	-40.54		
10028.31	Н	-43.54	-25.00	Pass
12535.12	Н	-45.58		
15028.61	Н			
Test mode:	LTE Band	d 7(5MHz)	Test channel:	Middle
Frequency (MHz)	Spurious	Emission	Limit (dPm)	Result
Frequency (MHZ)	Polarization	Level (dBm)	Limit (dBm)	Result
5070.00	Vertical	-35.58		
7605.00	V	-38.31		
10140.00	V	-36.35	-25.00	Pass
12675.00	V	-42.12		
15210.00	V			
5070.00	Horizontal	-37.58		
7605.00	Н	-43.23		
10140.00	Н	-42.12	-25.00	Pass
12675.00	Н	-43.28		
15210.00	Н			
Test mode:	LTE Band	d 7(5MHz)	Test channel:	Highest
Frequency (MHz)	Spurious	Emission	Limit (dBm)	Result
	Polarization	Level (dBm)		Result
5135.00	Vertical	-37.25		
7702.50	V	-38.51		
10270.00	V	-36.45	-25.00	Pass
12837.50	V	-43.12		
15405.00	V			
5405.00		-38.65		
5135.00	Horizontal	-30.05		
5135.00 7702.50	Horizontal	-40.25		
			-25.00	Pass
7702.50	Н	-40.25	-25.00	Pass

1. The emission behaviour belongs to narrowband spurious emission, all modes investigated and only worst case is reported.

2. Remark"---" means that the emission level is too low (20dB lower than the limit) to be measured

3. The emission levels of below 1 GHz are very lower (20dB lower than the limit) than the limit and not show in test report.



Test mode:	LTE Band	12(1.4MHz)	Test channel:	Lowest
		Emission		
Frequency (MHz)	Polarization	Level (dBm)	Limit (dBm)	Result
5005.00	Vertical	-35.54		
7507.50	V	-39.12	-25.00	
10010.00	V	-36.64		Pass
12512.50	V	-42.57		
15015.00	V			
5005.00	Horizontal	-38.31		
7507.50	Н	-41.58		
10010.00	Н	-43.51	-25.00	Pass
12512.50	Н	-45.58		
15015.00	Н			
Test mode:	LTE Band	12(1.4MHz)	Test channel:	Middle
Frequency (MHz)	Spurious	Emission	Limit (dBm)	Result
Frequency (MHZ)	Polarization	Level (dBm)		Result
5075.31	Vertical	-35.61		
7636.45	V	-37.31		
10131.52	V	-38.25	-25.00	Pass
12686.14	V	-42.45		
15228.31	V			
5075.31	Horizontal	-38.31		
7636.45	Н	-41.25		Pass
10131.52	Н	-44.58	-25.00	
12686.14	Н	-42.51		
15228.31	Н			
Test mode:		12(1.4MHz)	Test channel:	Highest
Frequency (MHz)	•	Emission	Limit (dBm)	Result
,	Polarization	Level (dBm)		
5156.21	Vertical	-37.55	4	
7705.61	V	-38.31	_	
10259.31	V	-36.25	-25.00	Pass
12878.86	V	-42.15	4	
15446.14	V			
5156.21	Horizontal	-38.55	4	
7705.61	Н	-41.51	4	
10259.31	Н	-46.28	-25.00	Pass
12878.86	Н	-45.52	4	
15446.14	Н			

1The emission behaviour belongs to narrowband spurious emission,all modes investigated and only worst case is reported.



Test mode:	LTE Band	I 17(5MHz)	Test channel:	Lowest
	Spurious	Emission		
Frequency (MHz)	Polarization	Level (dBm)	Limit (dBm)	Result
5012.54	Vertical	-32.61		
7523.51	V	-34.44		
10058.31	V	-35.35	-25.00	Pass
12573.21	V	-42.21		
15083.51	V			
5012.54	Horizontal	-37.25		
7523.51	Н	-41.23		
10058.31	Н	-43.28	-25.00	Pass
12573.21	Н	-43.02		
15083.51	Н			
Test mode:	LTE Band	l 17(5MHz)	Test channel:	Middle
	Spurious	Emission	Limit (dDm)	Result
Frequency (MHz)	Polarization	Level (dBm)	Limit (dBm)	Result
5013.14	Vertical	-35.58		
7621.05	V	-38.51		
10176.00	V	-37.23	-25.00	Pass
12601.00	V	-42.54		
15310.00	V			
5013.14	Horizontal	-38.61		
7621.05	Н	-42.12		
10176.00	Н	-43.28	-25.00	Pass
12601.00	Н	-43.12		
15310.00	Н			
Test mode:	LTE Band	l 17(5MHz)	Test channel:	Highest
Frequency (MHz)	Spurious	Emission	Limit (dBm)	Result
	Polarization	Level (dBm)	Elinit (dbiri)	result
5148.04	Vertical	-35.31	_	
7779.50	V	-38.62		
10245.00	V	-36.21	-25.00	Pass
12818.50	V	-42.51		
15437.00	V			
5148.04	Horizontal	-38.35		
7779.50	Н	-41.25		
10245.00	Н	-43.21	-25.00	Pass
12818.50	Н	-43.15		
15437.00	Н			

1The emission behaviour belongs to narrowband spurious emission,all modes investigated and only worst case is reported.



Test mode:	LTE Band	25(5MHz)	Test channel:	Lowest	
	Spurious Emission		Limit (dDm)	Decult	
Frequency (MHz)	Polarization	Level (dBm)	Limit (dBm)	Result	
5005.00	Vertical	-36.25			
7507.50	V	-37.12			
10010.00	V	-38.25	-13.00	Pass	
12512.50	V	-39.12			
15015.00	V				
5005.00	Horizontal	-38.23			
7507.50	Н	-39.21			
10010.00	Н	-40.28	-13.00	Pass	
12512.50	Н	-42.71			
15015.00	Н				
Test mode:	LTE Band	25(5MHz)	Test channel:	Middle	
Frequency (MHz)	Spurious	Emission	Limit (dBm)	Result	
Frequency (IVITIZ)	Polarization	Level (dBm)		Result	
5070.00	Vertical	-36.25			
7605.00	V	-37.24			
10140.00	V	-37.35	-13.00	Pass	
12675.00	V	-41.23			
15210.00	V				
5070.00	Horizontal	-34.21			
7605.00	Н	-40.38			
10140.00	Н	-42.83	-13.00	Pass	
12675.00	Н	-43.52			
15210.00	Н				
Test mode:	LTE Band	25(5MHz)	Test channel:	Highest	
Frequency (MHz)		Emission	Limit (dBm)	Result	
	Polarization	Level (dBm)	Linit (dBin)	rtesur	
5135.00	Vertical	-36.28			
7702.50	V	-37.58			
10270.00	V	-35.52	-13.00	Pass	
12837.50	V	-42.38			
15405.00	V				
5135.00	Horizontal	-38.95			
7702.50	Н	-40.92			
10270.00	Н	-42.51	-13.00	Pass	
12837.50	Н	-43.58			
15405.00	Н				

1The emission behaviour belongs to narrowband spurious emission,all modes investigated and only worst case is reported.



est mode(814-824MHz):	LTE	Band 26(5MHz)	Test channel:	Lowest
	Spi	urious Emission		
Frequency (MHz)	Polarization	Level (dBm)	– Limit (dBm)	Result
3576.56	Vertical	-36.28		
7507.50	V	-38.21		
10010.00	V	-35.25	-13.00	Pass
12512.50	V	-41.25		
15015.00	V			
5005.00	Horizontal	-35.21		
7507.50	Н	-40.58		
10010.00	Н	-43.31	-13.00	Pass
12512.50	Н	-43.31		
15015.00	Н			
est mode(814-824MHz):	LTE	Band 26(5MHz)	Test channel:	Middle
	Spi	urious Emission	Lingit (JDng)	Desult
Frequency (MHz)	Polarization	Level (dBm)	Limit (dBm)	Result
5070.00	Vertical	-33.85		
7605.00	V	-35.69		
10140.00	V	-38.31	-13.00	Pass
12675.00	V	-40.25		
15210.00	V			
5070.00	Horizontal	-37.25		
7605.00	Н	-42.31		
10140.00	Н	-43.51	-13.00	Pass
12675.00	Н	-42.22		
15210.00	Н			
est mode(814-824MHz):	LTE	Band 26(5MHz)	Test channel:	Highest
	Spi	urious Emission	Lincit (dDno)	Deput
Frequency (MHz)	Polarization	Level (dBm)	Limit (dBm)	Result
5135.00	Vertical	-35.55		
7702.50	V	-38.12		
10270.00	V	-38.62	-13.00	Pass
12837.50	V	-41.82		
15405.00	V			
5135.00	Horizontal	-38.12		
7702.50	Н	-40.82		
10270.00	Н	-41.52	-13.00	Pass
12837.50	Н	-43.28]	
15405.00	Н			

1The emission behaviour belongs to narrowband spurious emission,all modes investigated and only worst case is reported.



Test mode(824-849MHz):	LTE	Band 26(5MHz)	Test channel:	Lowest
		urious Emission		
Frequency (MHz)	Polarization	Level (dBm)	Limit (dBm)	Result
3975.14	Vertical	-35.3.1		
7645.12	V	-38.31		
10078.31	V	-36.29	-13.00	Pass
12328.25	V	-42.91		
13145.10	V			
3975.14	Horizontal	-38.12		
7645.12	Н	-40.27		
10078.31	Н	-43.82	-13.00	Pass
12328.25	Н	-45.52		
13145.10	Н			
Test mode(824-849MHz):	LTE	Band 26(5MHz)	Test channel:	Middle
Frequency (MHz)	Spi	urious Emission	Limit (dBm)	Result
Frequency (MHZ)	Polarization	Level (dBm)	Limit (dBm)	Result
3715.85	Vertical	-35.45		
7645.31	V	-37.25		
10256.55	V	-36.12	-13.00	Pass
12573.12	V	-42.35		
15145.31	V			
3715.85	Horizontal	-38.85		
7645.31	Н	-40.12		
10256.55	Н	-42.51	-13.00	Pass
12573.12	Н	-43.25		
15145.31	Н			
Test mode(824-849MHz):	LTE	Band 26(5MHz)	Test channel:	Highest
Frequency (MHz)	Spi	urious Emission	Limit (dBm)	Result
Frequency (Miriz)	Polarization	Level (dBm)		Result
3828.31	Vertical	-35.86		
7862.12	V	-37.31		
10214.36	V	-36.58	-13.00	Pass
12518.15	V	-42.53		
15536.14	V			
3828.31	Horizontal	-34.25		
7862.12	Н	-40.12		
10214.36	Н	-43.15	-13.00	Pass
12518.15	Н	-45.78		
15536.14	Н			

1The emission behaviour belongs to narrowband spurious emission,all modes investigated and only worst case is reported.



Test mode	LTE	Band 38(5MHz)	Test channel:	Lowest
	Spι	rious Emission		Decult
Frequency (MHz)	Polarization	Level (dBm)	Limit (dBm)	Result
2596.61	Vertical	-35.31		
5136.54	V	-36.21		
10756.13	V	-35.25	-25.00	Pass
12847.63	V	-42.12		
13768.31	V			
2596.61	Horizontal	-37.12		
5136.54	Н	-40.25		
10756.13	Н	-43.28	-25.00	Pass
12847.63	Н	-45.82		
13768.31	Н			
Test mode	LTE	Band 38(5MHz)	Test channel:	Middle
Frequency (MHz)	Spi	rious Emission	Limit (dBm)	Result
Frequency (MITZ)	Polarization	Level (dBm)	Linit (dBill)	Result
2686.56	Vertical	-32.52		
5386.61	V	-38.14		
10756.25	V	-36.25	-25.00	Pass
12759.31	V	-42.45		
15259.47	V			
2686.56	Horizontal	-38.12		
5386.61	Н	-40.12		
10756.25	Н	-43.58	-25.00	Pass
12759.31	Н	-43.28		
15259.47	Н			
Test mode	LTE	Band 38(5MHz)	Test channel:	Highest
Frequency (MHz)	Spi	rious Emission	Limit (dBm)	Result
	Polarization	Level (dBm)		Result
2702.64	Vertical	-35.12		
5432.51	V	-38.01		
10857.31	V	-38.31	-25.00	Pass
12789.12	V	-40.58		
16145.32	V			
2702.64	Horizontal	-35.21		
5432.51	Н	-40.76		
10857.31	Н	-43.12	-25.00	Pass
12789.12	Н	-44.02		
16145.32	Н			

1The emission behaviour belongs to narrowband spurious emission,all modes investigated and only worst case is reported.



Test mode	LTE	Band 41(5MHz)	Test channel:	Lowest
	Spu	rious Emission		D It
Frequency (MHz)	Polarization	Level (dBm)	Limit (dBm)	Result
4981.12	Vertical	-32.12		
9931.25	V	-38.25		
10057.58	V	-38.22	-25.00	Pass
12157.31	V	-42.45		
13243.58	V			
4981.12	Horizontal	-37.85		
9931.25	Н	-41.28		
10057.58	Н	-43.28	-25.00	Pass
12157.31	Н	-45.21		
13243.58	Н			
Test mode	LTE	Band 41(5MHz)	Test channel:	Middle
Frequency (MHz)	Spu	rious Emission	Limit (dBm)	Result
	Polarization	Level (dBm)	Linit (dBiii)	Result
5014.64	Vertical	-35.51		
10031.21	V	-37.12		
12364.61	V	-37.25	-25.00	Pass
13573.73	V	-41.01		
15248.27	V			
5014.64	Horizontal	-35.12		
10031.21	Н	-43.10		
12364.61	Н	-42.12	-25.00	Pass
13573.73	Н	-45.01		
15248.27	Н			
Test mode	LTE	Band 41(5MHz)	Test channel:	Highest
Frequency (MHz)	· · · · ·	rious Emission	Limit (dBm)	Result
	Polarization	Level (dBm)	Linit (dbiii)	Roodit
5009.64	Vertical	-36.35		
10243.01	V	-38.12		
12104.43	V	-38.12	-25.00	Pass
13593.15	V	-42.14		
15321.14	V			
5009.64	Horizontal	-38.02		
10243.01	Н	-41.85		
12104.43	Н	-43.02	-25.00	Pass
13593.15	Н	-43.28		
15321.14	Н			

1The emission behaviour belongs to narrowband spurious emission,all modes investigated and only worst case is reported.



Test mode:	LTE Band 6	66(1.4MHz)	Test channel:	Lowest
Frequency	Spurious	Emission	Linsit (dDms)	Deput
(MHz)	Polarization	Level (dBm)	Limit (dBm)	Result
3421.40	Vertical	-35.12		
5132.10	V	-38.32		
6842.80	V	-35.12	-13.00	Pass
8553.50	V	-42.52		
10264.20	V			
3421.40	Horizontal	-38.12		
5132.10	Н	-41.01		
6842.80	Н	-43.28	-13.00	Pass
8553.50	Н	-45.12		
10264.20	Н			
Test mode:	LTE Band 6	6(1.4MHz)	Test channel:	Middle
Frequency	Spurious	Emission	Limit (dRm)	Result
(MHz)	Polarization	Level (dBm)	Limit (dBm)	Result
3465.00	Vertical	-38.24		
5197.50	V	-39.23		
6930.00	V	-38.10	-13.00	Pass
8662.50	V	-42.25		
10395.00	V			
3465.00	Horizontal	-38.12		
5197.50	Н	-40.85		
6930.00	Н	-43.72	-13.00	Pass
8662.50	Н	-43.12		
10395.00	Н			
Test mode:	LTE Band 6	6(1.4MHz)	Test channel:	Highest
Frequency	Spurious	Emission	Limit (dBm)	Result
(MHz)	Polarization	Level (dBm)		Result
3508.60	Vertical	-35.85		
5262.90	V	-31.3.		
7017.20	V	-36.35	-13.00	Pass
8771.50	V	-42.21	_	
10525.80	V			
3508.60	Horizontal	-37.02	_	
5262.90	Н	-43.25		
7017.20	Н	-45.12	-13.00	Pass
8771.50	Н	-46.12		
10525.80	Н			

1The emission behaviour belongs to narrowband spurious emission,all modes investigated and only worst case is reported.

2Remark"----" means that the emission level is too low (20dB lower than the limit) to be measured

3The emission levels of below 1 GHz are very lower (20dB lower than the limit) than the limit and not show in test report.

The emission behaviour belongs to narrowband spurious emission, all modes investigated and only worst



16 QAM Mode:				
Test mode:	LTE Band	2 (1.4MHz)	Test channel:	Lowest
Frequency (MHz)	Spurious	Emission	Limit (dBm)	Result
Frequency (MHZ)	Polarization	Level (dBm)	Limit (ubin)	Result
3701.40	Vertical	-35.01		
5552.10	V	-37.32	-13.00	
7402.80	V	-35.20		Pass
9253.50	V	-42.12		
11104.20	V			
3701.40	Horizontal	-35.35		
5552.10	Н	-40.25		
7402.80	Н	-43.52	-13.00	Pass
9253.50	Н	-44.54		
11104.20	Н			
Test mode:	LTE Band	2 (1.4MHz)	Test channel:	Middle
	Spurious	Emission	Linsit (dDma)	Decult
Frequency (MHz)	Polarization	Level (dBm)	Limit (dBm)	Result
3760.00	Vertical	-35.85		
5640.00	V	-37.12		
7520.00	V	-38.15	-13.00	Pass
9400.00	V	-42.53		
11280.00	V			
3760.00	Horizontal	-38.12		
5640.00	Н	-41.28		Pass
7520.00	Н	-43.12	-13.00	
9400.00	Н	-45.31		
11280.00	Н			
Test mode:	LTE Band	2 (1.4MHz)	Test channel:	Highest
	Spurious	Emission	Limit (dDm)	Result
Frequency (MHz)	Polarization	Level (dBm)	Limit (dBm)	Result
3818.60	Vertical	-35.12		
5727.90	V	-38.23]	
7637.20	V	-37.21	-13.00	Pass
9546.50	V	-43.24]	
11455.80	V]	
3818.60	Horizontal	-38.28		
5727.90	Н	-40.58]	
7637.20	Н	-43.12	-13.00	Pass
9546.50	Н	-43.82]	
11455.80	Н			

1 The emission behaviour belongs to narrowband spurious emission,all modes investigated and only worst case is reported.

- 2 Remark"---" means that the emission level is too low (20dB lower than the limit) to be measured
- 3 The emission levels of below 1 GHz are very lower (20dB lower than the limit) than the limit and not show in test report.



Test mode:	LTE Band	4(1.4MHz)	Test channel:	Lowest
		Emission		
Frequency (MHz)	Polarization	Level (dBm)	Limit (dBm)	Result
3421.40	Vertical	-36.28		
5132.10	V	-37.35		
6842.80	V	-33.28	-13.00	Pass
8553.50	V	-44.92		
10264.20	V			
3421.40	Horizontal	-38.12		
5132.10	Н	-40.58		
6842.80	Н	-43.85	-13.00	Pass
8553.50	Н	-45.12		
10264.20	Н			
Test mode:	LTE Band	4(1.4MHz)	Test channel:	Middle
Frequency (MHz)	Spurious	Emission	Limit (dBm)	Result
Frequency (IVITIZ)	Polarization	Level (dBm)	Liniit (dbin)	Result
3465.00	Vertical	-35.21		
5197.50	V	-38.25		
6930.00	V	-36.31	-13.00	Pass
8662.50	V	-42.14		
10395.00	V			
3465.00	Horizontal	-38.25		
5197.50	Н	-41.01		
6930.00	Н	-43.82	-13.00	Pass
8662.50	Н	-42.12		
10395.00	Н			
Test mode:	LTE Band	4(1.4MHz)	Test channel:	Highest
Frequency (MHz)	Spurious	Emission	Limit (dBm)	Result
	Polarization	Level (dBm)	Einin (dDin)	Result
3508.60	Vertical	-38.21	_	
5262.90	V	-38.02		
7017.20	V	-33.78	-13.00	Pass
8771.50	V	-41.21		
10525.80	V			
3508.60	Horizontal	-37.25		
5262.90	Н	-40.12	_	
7017.20	Н	-43.52	-13.00	Pass
			-13.00	
8771.50	H	-43.12		

1 The emission behaviour belongs to narrowband spurious emission, all modes investigated and only worst case is reported.

- 2 Remark"---" means that the emission level is too low (20dB lower than the limit) to be measured
- 3 The emission levels of below 1 GHz are very lower (20dB lower than the limit) than the limit and not show in test report.



Test meder			Testshermel	1
Test mode:	LTE Band 5(1.4MHz) Spurious Emission		Test channel:	Lowest
Frequency (MHz)	Polarization	Level (dBm)	Limit (dBm)	Result
1649.40	Vertical	-37.52		
2474.10	V	-38.12		
3298.80	V	-37.21	-13.00	Pass
4123.50	V	-42.51		
4948.20	V			
1649.40	Horizontal	-37.35	-13.00	Pass
2474.10	Н	-41.25		
3298.80	Н	-43.25		
4123.50	Н	-45.12		
4948.20	Н			
Test mode:	LTE Band	5(1.4MHz)	Test channel:	Middle
Frequency (MHz)	Spurious	Emission	Limit (dDm)	Result
	Polarization	Level (dBm)	Limit (dBm)	
1673.00	Vertical	-35.31	-13.00	Pass
2509.50	V	-35.12		
3346.00	V	-38.01		
4182.50	V	-41.25		
5019.00	V			
1673.00	Horizontal	-38.12	-13.00	Pass
2509.50	Н	-41.35		
3346.00	Н	-43.25		
4182.50	Н	-45.78		
5019.00	Н			
Test mode:	LTE Band 5(1.4MHz)		Test channel:	Highest
Frequency (MHz)	Spurious		Limit (dBm)	Result
	Polarization	Level (dBm)		
1696.60	Vertical	-36.32	-13.00	Pass
2544.90	V	-32.12		
3393.20	V	-35.21		
4241.50	V	-41.83		
5089.80	V			
1696.60	Horizontal	-37.29	-13.00	
2544.90	Н	-41.28		
3393.20	Н	-43.12		Pass
4241.50	Н	-42.53		
5089.80	Н			

1 The emission behaviour belongs to narrowband spurious emission, all modes investigated and only worst case is reported.

2 Remark"---" means that the emission level is too low (20dB lower than the limit) to be measured

3 The emission levels of below 1 GHz are very lower (20dB lower than the limit) than the limit and not show in test report.



Test mode:	LTE Band	d 7(5MHz)	Test channel:	Lowest
	Spurious	Emission	Line it (JDne)	Desult
Frequency (MHz)	Polarization	Level (dBm)	Limit (dBm)	Result
5005.00	Vertical	-36.38		
7507.50	V	-38.12		
10010.00	V	-36.28	-25.00	Pass
12512.50	V	-42.11		
15015.00	V			
5005.00	Horizontal	-32.12		
7507.50	Н	-40.99		
10010.00	Н	-44.86	-25.00	Pass
12512.50	Н	-45.85		
15015.00	Н			
Test mode:	LTE Band	d 7(5MHz)	Test channel:	Middle
Eroguopov (MHz)	Spurious	Emission	Limit (dPm)	Popult
Frequency (MHz)	Polarization	Level (dBm)	Limit (dBm)	Result
5070.00	Vertical	-35.28		
7605.00	V	-36.12	-25.00	Pass
10140.00	V	-38.34		
12675.00	V	-43.74		
15210.00	V			
5070.00	Horizontal	-38.27		
7605.00	Н	-43.39		
10140.00	Н	-43.74	-25.00	Pass
12675.00	Н	-44.28		
15210.00	Н			
Test mode:	LTE Band	d 7(5MHz)	Test channel:	Highest
Frequency (MHz)	Spurious	Emission	Limit (dBm)	Result
	Polarization	Level (dBm)		Result
5135.00	Vertical	-36.14		
7702.50	V	-38.28		
10270.00	V	-36.12	-25.00	Pass
12837.50	V	-42.58		
15405.00	V			
5135.00	Horizontal	-35.18		
7702.50	Н	-40.12		
10270.00	Н	-43.74	-25.00	Pass
12837.50	Н	-43.61	_	
15405.00	Н			

1 The emission behaviour belongs to narrowband spurious emission, all modes investigated and only worst case is reported.

2 Remark"---" means that the emission level is too low (20dB lower than the limit) to be measured

3 The emission levels of below 1 GHz are very lower (20dB lower than the limit) than the limit and not show in test report.



			- / -	
Test mode:		12 (1.4MHz)	Test channel:	Lowest
Frequency (MHz)	Spurious Polarization	Emission Level (dBm)	– Limit (dBm)	Result
3701.40	Vertical	-35.98		
5552.10	V	-38.63	-	
7402.80	V	-36.28	-13.00	Pass
9253.50	V	-41.52	-	
11104.20	V		-	
3701.40	Horizontal	-38.09		
5552.10	Н	-42.25		
7402.80	Н	-44.58	-13.00	Pass
9253.50	Н	-43.86		
11104.20	Н			
Test mode:	LTE Band	12 (1.4MHz)	Test channel:	Middle
	Spurious	Emission		D It
Frequency (MHz)	Polarization	Level (dBm)	– Limit (dBm)	Result
3760.00	Vertical	-38.28		
5640.00	V	-37.02	-13.00	
7520.00	V	-39.33		Pass
9400.00	V	-42.83		
11280.00	V			
3760.00	Horizontal	-38.83		
5640.00	Н	-41.02		Pass
7520.00	Н	-43.74	-13.00	
9400.00	Н	-44.28		
11280.00	Н			
Test mode:	LTE Band	12 (1.4MHz)	Test channel:	Highest
Frequency (MHz)	Spurious	Emission	Limit (dBm)	Result
	Polarization	Level (dBm)		Result
3818.60	Vertical	-38.12		
5727.90	V	-37.82		
7637.20	V	-38.33	-13.00	Pass
9546.50	V	-43.72	_	
11455.80	V			
3818.60	Horizontal	-38.38		
5727.90	Н	-41.07	13.00 Pa	
7637.20	Н	-43.65		Pass
9546.50	Н	-43.84		
11455.80	Н			

1 The emission behaviour belongs to narrowband spurious emission, all modes investigated and only worst case is reported.

2 Remark"---" means that the emission level is too low (20dB lower than the limit) to be measured

3 The emission levels of below 1 GHz are very lower (20dB lower than the limit) than the limit and not show in test report.



Test mode:	LTE Band	17(5MHz)	Test channel:	Lowest
	Spurious	Emission	Linsit (dDno)	Decult
Frequency (MHz)	Polarization	Level (dBm)	Limit (dBm)	Result
5005.00	Vertical	-33.66		
7507.50	V	-32.31		
10010.00	V	-35.98	-25.00	Pass
12512.50	V	-43.31		
15015.00	V			
5005.00	Horizontal	-38.10		
7507.50	Н	-41.82		
10010.00	Н	-43.53	-25.00	Pass
12512.50	Н	-43.15		
15015.00	Н			
Test mode:	LTE Band	17(5MHz)	Test channel:	Middle
	Spurious	Emission	Lineit (JDne)	Desult
Frequency (MHz)	Polarization	Level (dBm)	Limit (dBm)	Result
5070.00	Vertical	-35.12		
7605.00	V	-38.45	-25.00	Pass
10140.00	V	-37.02		
12675.00	V	-42.63		
15210.00	V			
5070.00	Horizontal	-37.82		
7605.00	Н	-41.35		
10140.00	Н	-43.12	-25.00	Pass
12675.00	Н	-44.08		
15210.00	Н			
Test mode:	LTE Band	17(5MHz)	Test channel:	Highest
Frequency (MHz)	Spurious	Emission	Limit (dBm)	Result
	Polarization	Level (dBm)		Result
5135.00	Vertical	-38.09		
7702.50	V	-38.81		
10270.00	V	-36.21	-25.00	Pass
12837.50	V	-42.52		
15405.00	V			
5135.00	Horizontal	-37.61		
7702.50	Н	-43.83		
10270.00	Н	-42.57	-25.00	Pass
12837.50	Н	-42.96		

1The emission behaviour belongs to narrowband spurious emission,all modes investigated and only worst case is reported.

2Remark"---" means that the emission level is too low (20dB lower than the limit) to be measured3The emission levels of below 1 GHz are very lower (20dB lower than the limit) than the limit and not show in test report.



Test mode:	LTE Band	25(5MHz)	Test channel:	Lowest
	Spurious	Emission		
Frequency (MHz)	Polarization	Level (dBm)	Limit (dBm)	Result
5004.75	Vertical	-33.21		
7506.31	V	-38.85		
10008.13	V	-36.38	-13.00	Pass
12217.58	V	-41.02		
13563.14	V			
5004.75	Horizontal	-38.91		
7506.31	Н	-41.05		
10008.13	Н	-43.75	-13.00	Pass
12217.58	Н	-43.54		
13563.14	Н			
Test mode:	LTE Band	25(5MHz)	Test channel:	Middle
Eroquopov (MHz)	Spurious	Emission	Limit (dPm)	Result
Frequency (MHz)	Polarization	Level (dBm)	Limit (dBm)	Result
5058.31	Vertical	-35.86		
7601.58	V	-35.12	-13.00	
10124.33	V	-36.74		Pass
12659.45	V	-41.08		
15365.86	V			
5058.31	Horizontal	-37.36		
7601.58	Н	-41.08		Pass
10124.33	Н	-42.84	-13.00	
12659.45	Н	-45.02		
15365.86	Н			
Test mode:	LTE Band	25(5MHz)	Test channel:	Highest
Frequency (MHz)	Spurious	Emission	Limit (dBm)	Result
Frequency (MHZ)	Polarization	Level (dBm)		Result
5205.21	Vertical	-33.28		
7778.25	V	-34.02		
10269.21	V	-38.85	-13.00	Pass
12705.02	V	-42.84		
15386.26	V			
5205.21	Horizontal	-37.23		
7778.25	Н	-40.57		
10269.21	Н	-43.12	-13.00	Pass
12705.02	Н	-45.86	7	
15386.26	Н			

4The emission behaviour belongs to narrowband spurious emission,all modes investigated and only worst case is reported.

5Remark"---" means that the emission level is too low (20dB lower than the limit) to be measured 6The emission levels of below 1 GHz are very lower (20dB lower than the limit) than the limit and not show in test report.



Test mode(814-824MHz):	ITE	Band 26(5MHz)	Test channel:	Lowest
		urious Emission	iest clidillel.	LOWESI
Frequency (MHz)	Polarization	Level (dBm)	Limit (dBm)	Result
3586.31	Vertical	-35.61		
7510.15	V	-35.63		
10012.32	V	-32.81	-13.00	Pass
12503.76	V	-43.07		
15021.15	V			
3586.31	Horizontal	-37.25		
7510.15	Н	-41.53		
10012.32	Н	-43.87	-13.00	Pass
12503.76	Н	-45.74		
15021.15	Н			
Test mode(814-824MHz):	LTE	Band 26(5MHz)	Test channel:	Middle
	Spi	urious Emission	Lineit (dDne)	Desult
Frequency (MHz)	Polarization	Level (dBm)	Limit (dBm)	Result
5059.31	Vertical	-35.61		
7635.57	V	-37.62	-13.00	Pass
10128.61	V	-37.65		
12583.31	V	-42.84		
15227.30	V			
5059.31	Horizontal	-37.12		
7635.57	Н	-42.53		Pass
10128.61	Н	-43.54	-13.00	
12583.31	Н	-48.13		
15227.30	Н			
Test mode(814-824MHz):	LTE	Band 26(5MHz)	Test channel:	Highest
	Spi	urious Emission		Desult
Frequency (MHz)	Polarization	Level (dBm)	Limit (dBm)	Result
5205.31	Vertical	-35.21		
7715.48	V	-38.25		
10286.25	V	-35.31	-13.00	Pass
12705.47	V	-42.86		
15408.31	V			
5205.31	Horizontal	-38.74		
7715.48	Н	-41.28		
10286.25	Н	-43.82	-13.00 P	Pass
12705.47	Н	-45.05		
15408.31	Н			

4The emission behaviour belongs to narrowband spurious emission,all modes investigated and only worst case is reported.

5Remark"---" means that the emission level is too low (20dB lower than the limit) to be measured6The emission levels of below 1 GHz are very lower (20dB lower than the limit) than the limit and not show in test report.



Test mode(824-849MHz):		Band 26(5MHz)	Test channel:	Lowest
		LTE Band 26(5MHz)		Lowest
Frequency (MHz)	Sp Polarization	urious Emission Level (dBm)	Limit (dBm)	Result
3925.64	Vertical	-36.21		
7658.10	V	-38.05		
10082.51	V	-37.35	-13.00	Pass
12423.42	V	-41.51		
13178.32	V			
3925.64	Horizontal	-38.21		
7658.10	Н	-44.51		
10082.51	Н	-44.55	-13.00	Pass
12423.42	Н	-46.38		
13178.32	Н			
Test mode(824-849MHz):	LTE	Band 26(5MHz)	Test channel:	Middle
	Sp	urious Emission	Limit (dDm)	Desult
Frequency (MHz)	Polarization	Level (dBm)	Limit (dBm)	Result
3802.15	Vertical	-36.88		
7623.48	V	-34.27		
10261.25	V	-36.85	-13.00	Pass
12610.45	V	-42.87		
15261.25	V			
3802.15	Horizontal	-37.56		
7623.48	Н	-40.58		
10261.25	Н	-43.51	-13.00	Pass
12610.45	н	-43.25		
15261.25	Н			
Test mode(824-849MHz):	LTE	Band 26(5MHz)	Test channel:	Highest
Fraguanay (MHz)	Sp	urious Emission	Limit (dPm)	Result
Frequency (MHz)	Polarization	Level (dBm)	Limit (dBm)	Result
3828.48	Vertical	-37.22		
7862.01	V	-38.12		
10224.47	V	-38.35	-13.00	Pass
12520.11	V	-42.87		
15503.47	V			
3828.48	Horizontal	-38.62		
7862.01	Н	-40.27		
10224.47	Н	-43.14	-13.00 Pa	Pass
12520.11	Н	-45.87		
15503.47	Н			

4The emission behaviour belongs to narrowband spurious emission,all modes investigated and only worst case is reported.

5Remark"---" means that the emission level is too low (20dB lower than the limit) to be measured6The emission levels of below 1 GHz are very lower (20dB lower than the limit) than the limit and not show in test report.



Test mode	LTE	Band 38(5MHz)	Test channel:	Lowest
_ /	Spu	rious Emission		
Frequency (MHz)	Polarization	Level (dBm)	Limit (dBm)	Result
2596.86	Vertical	-33.24		
5136.01	V	-37.12		
10758.73	V	-38.82	-25.00	Pass
12801.25	V	-42.35		
13773.40	V			
2596.86	Horizontal	-38.12		
5136.01	Н	-43.71		
10758.73	Н	-41.22	-25.00	Pass
12801.25	Н	-46.45		
13773.40	Н			
Test mode	LTE	Band 38(5MHz)	Test channel:	Middle
	Spu	rious Emission	Limit (dBm)	Decult
Frequency (MHz)	Polarization	Level (dBm)	Limit (dbm)	Result
2698.31	Vertical	-35.36		
5395.48	V	-38.12		
10761.30	V	-36.87	-25.00	Pass
12801.38	V	-42.87		
15274.58	V			
2698.31	Horizontal	-34.02		
5395.48	Н	-41.52		
10761.30	Н	-43.54	-25.00	Pass
12801.38	Н	-48.74		
15274.58	Н			
Test mode	LTE	Band 38(5MHz)	Test channel:	Highest
Frequency (MHz)	Spu	rious Emission	Limit (dBm)	Result
	Polarization	Level (dBm)		Result
2708.64	Vertical	-36.54		
5432.14	V	-39.12		
10758.82	V	-37.85	-25.00	Pass
12874.10	V	-43.54		
16384.25	V			
2708.64	Horizontal	-38.93		
5432.14	Н	-43.25		
10758.82	Н	-43.87	-25.00	Pass
12874.10	Н	-45.57		
16384.25	Н			

4The emission behaviour belongs to narrowband spurious emission,all modes investigated and only worst case is reported.

5Remark"----" means that the emission level is too low (20dB lower than the limit) to be measured6The emission levels of below 1 GHz are very lower (20dB lower than the limit) than the limit and not show in test report.



Test mode	LTE	Band 41(5MHz)	Test channel:	Lowest
	Spu	rious Emission	Linsit (dDno)	Decult
Frequency (MHz)	Polarization	Level (dBm)	Limit (dBm)	Result
4976.31	Vertical	-35.31		
9928.31	V	-36.75		
10102.27	V	-35.98	-25.00	Pass
12168.35	V	-42.15		
13258.31	V			
4976.31	Horizontal	-36.54		
9928.31	Н	-44.25		
10102.27	Н	-40.47	-25.00	Pass
12168.35	Н	-45.15		
13258.31	Н			
Test mode	LTE	Band 41(5MHz)	Test channel:	Middle
Frequency (MHz)	Spu	rious Emission	Limit (dBm)	Pocult
Frequency (MHZ)	Polarization	Level (dBm)		Result
5028.66	Vertical	-36.94		
10004.63	V	-38.21	-25.00	Pass
12358.47	V	-36.12		
13526.54	V	-40.69		
15238.31	V			
5028.66	Horizontal	-38.12		
10004.63	Н	-41.95		
12358.47	Н	-43.78	-25.00	Pass
13526.54	Н	-43.68		
15238.31	Н			
Test mode	LTE	Band 41(5MHz)	Test channel:	Highest
Frequency (MHz)	Spu	rious Emission	Limit (dBm)	Result
Fiequency (MHZ)	Polarization	Level (dBm)		Result
5010.36	Vertical	-35.83		
10257.21	V	-39.12		
12203.47	V	-35.86	-25.00	Pass
13583.28	V	-41.28		
15337.25	V			1
5010.36	Horizontal	-37.52		
10257.21	Н	-41.75	-25.00	
12203.47	Н	-43.67		Pass
13583.28	Н	-44.46		
15337.25	Н			

4The emission behaviour belongs to narrowband spurious emission,all modes investigated and only worst case is reported.

5Remark"----" means that the emission level is too low (20dB lower than the limit) to be measured6The emission levels of below 1 GHz are very lower (20dB lower than the limit) than the limit and not show in test report.



			•	
Test mode:	LTE Band 6	66(1.4MHz)	Test channel:	Lowest
		Emission		
Frequency (MHz)	Polarization	Level (dBm)	Limit (dBm)	Result
3420.47	Vertical	-35.97		
5133.21	V	-39.01		
6847.25	V	-36.95	-13.00	Pass
8552.15	V	-42.12		
10263.25	V			
3420.47	Horizontal	-37.56		
5133.21	Н	-40.14		
6847.25	Н	-43.82	-13.00	Pass
8552.15	Н	-44.69		
10263.25	Н			
Test mode:	LTE Band 6	66(1.4MHz)	Test channel:	Middle
Frequency (MHz)	Spurious	Emission	Limit (dBm)	Result
Frequency (MHZ)	Polarization	Level (dBm)	Linii (dBiii)	Result
3458.31	Vertical	-38.65		
5198.65	V	-37.29		
6929.54	V	-38.12	-13.00	Pass
8658.31	V	-42.73		
10402.69	V			
3458.31	Horizontal	-36.28		
5198.65	Н	-40.12		
6929.54	Н	-43.85	-13.00	Pass
8658.31	Н	-43.21		
10402.69	Н			
Test mode:	LTE Band 6	66(1.4MHz)	Test channel:	Highest
Frequency (MHz)	•	Emission	Limit (dBm)	Result
	Polarization	Level (dBm)		Result
3510.58	Vertical	-35.35	_	
5263.58	V	-34.23	4	
7023.36	V	-35.89	-13.00	Pass
8782.31	V	-42.31		
10535.75	V			
3510.58	Horizontal	-37.12		
5263.58	Н	-40.25	4	
7023.36	Н	-43.64	-13.00	Pass
8782.31	Н	-44.25	_	
10535.75	Н			

4The emission behaviour belongs to narrowband spurious emission,all modes investigated and only worst case is reported.

5Remark"---" means that the emission level is too low (20dB lower than the limit) to be measured 6The emission levels of below 1 GHz are very lower (20dB lower than the limit) than the limit and not show in test report.



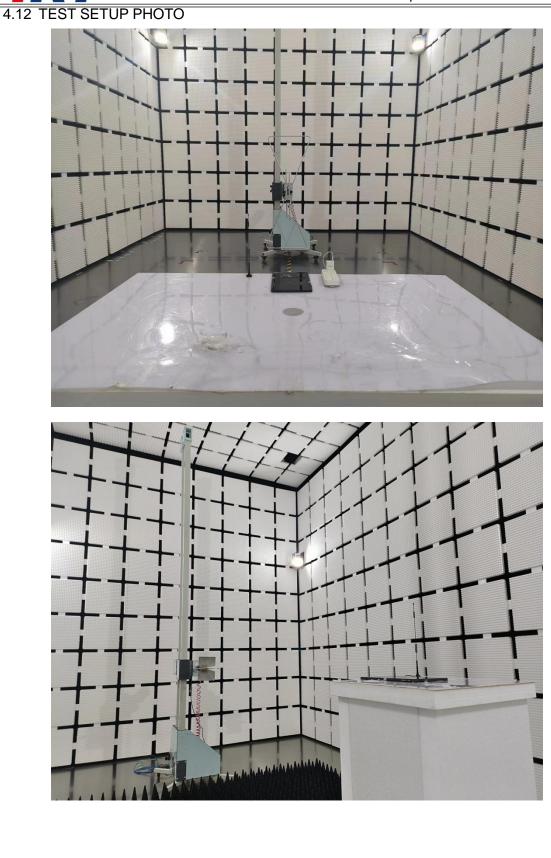
Test Requirement:	Part 2.1055(a)(1)(b), Part 22.355
	Part 24.235 , Part 27.54, Part 90.213
Test Method:	ANSI C63.26:2015
Limit:	2.5ppm(Part 22)
	Within the authorized bands of operation(Part 24, Part 27)
Test setup:	Temperature Chamber
	Spectrum analyzer EUT Att. Variable Power Supply
	Variable Power Supply Note: Measurement setup for testing on Antenna connector
Test procedure:	 The equipment under test was connected to an external DC power supply and input rated voltage. RF output was connected to a frequency counter or spectro analyzer via feed through attenuators. The EUT was placed inside the temperature chamber. Set the spectrum analyzer RBW low enough to obtain the desir frequency resolution and measure EUT 25°C operating frequer as reference frequency. Turn EUT off and set the chamber temperature to -20°C. After the temperature stabilized for approximately 30 minutes recorded the frequency. Repeat step measure with 10°C increased per stage until the temperature of +50°C reached.
Test Instruments:	Refer to section 3 for details
Test mode:	Refer to section 4.1 for details
Test results:	Pass
Remark:	If all frequencies stability are comply with the lower limit, then all resu
	can be considered qualified



4.11 FREQUENCY STABI	LITY V.S. VOLTAGE MEASUREMENT
Test Requirement:	Part 2.1055(d)(1)(2) Part 22.355 Part 24.235 Part 27.54
	Part 90.213
Test Method:	ANSI C63.26:2015
Limit:	2.5ppm
	Band II & Band VII should be within authorized band.
Test setup:	Temperature Chamber
Test procedure:	Spectrum analyzer Att. Variable Power Supply Note : Measurement setup for testing on Antenna connector 1. Set chamber temperature to 20°C. Use a variable DC power source to power the EUT and set the voltage to rated voltage. 2. Set the spectrum analyzer RBW low enough to obtain the desired
	frequency resolution and recorded the frequency.
	3. Reduce the input voltage to specified extreme voltage variation (+/-
	15%) and endpoint, record the maximum frequency change. Refer to section 3 for details
Test Instruments:	
Test mode:	Refer to section 4.1 for details
Test results:	Pass
Remark:	1. Manufacturer specified the battery operating end point voltage is
	3.61VDC, max voltage is 4.18VDC.
	2. If all frequencies stability are comply with the lower limit, then all
Note: Please refer to Appendix Fot	results can be considered qualified the Appendix Test Data

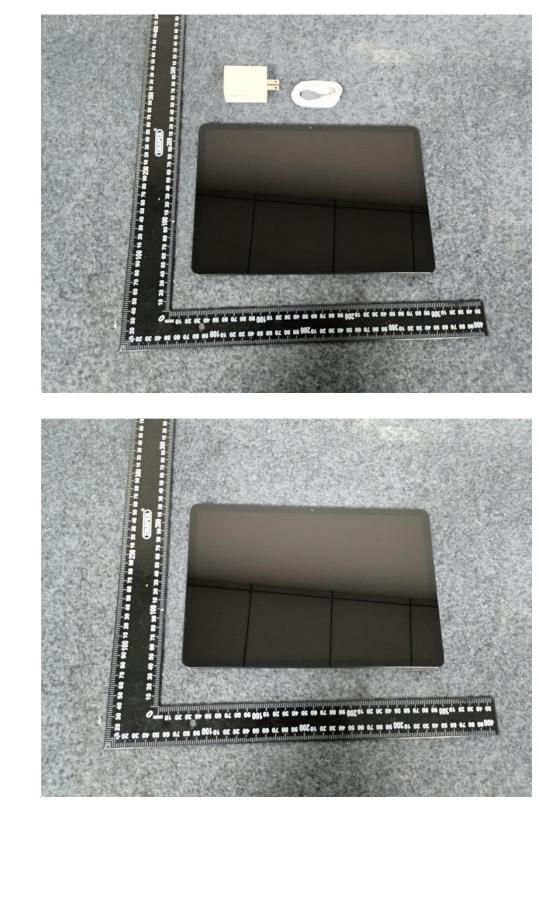
Note: Please refer to Appendix Fof the Appendix Test Data.



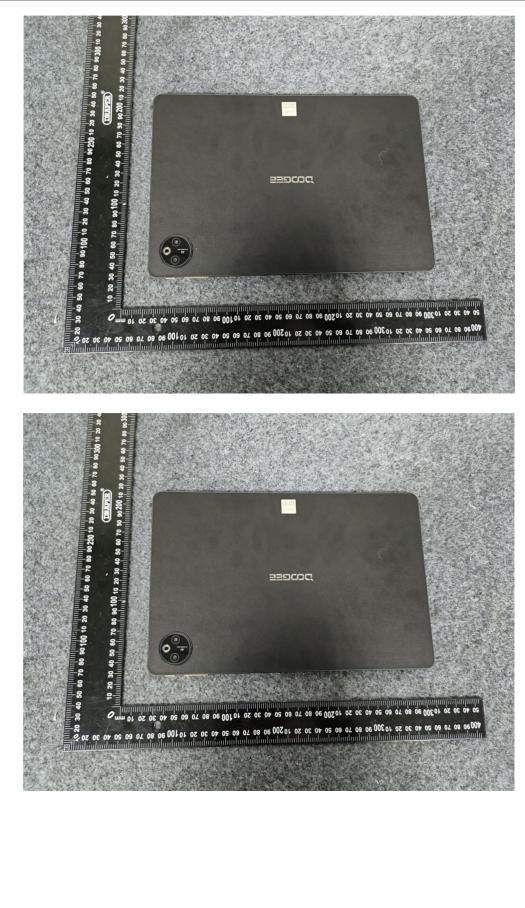




4.13 PHOTOS OF EUT









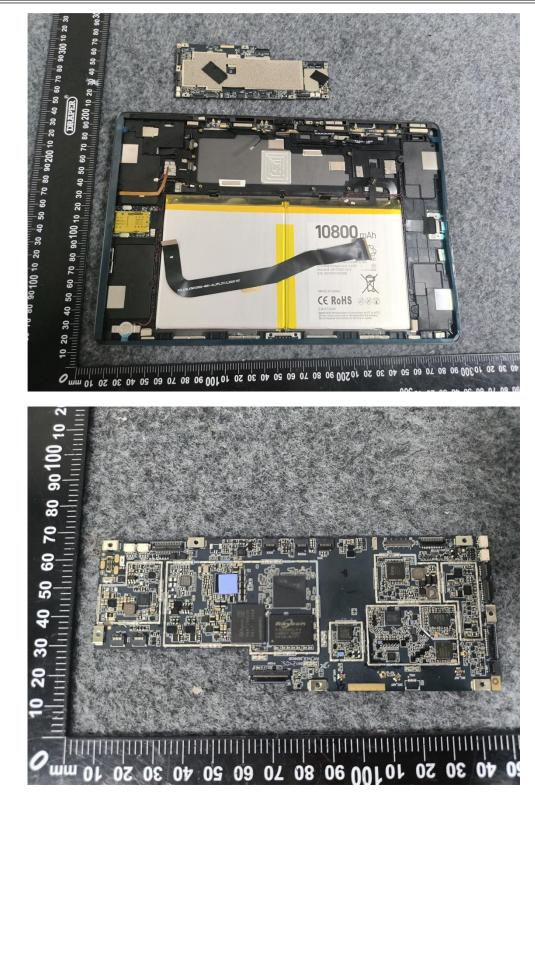






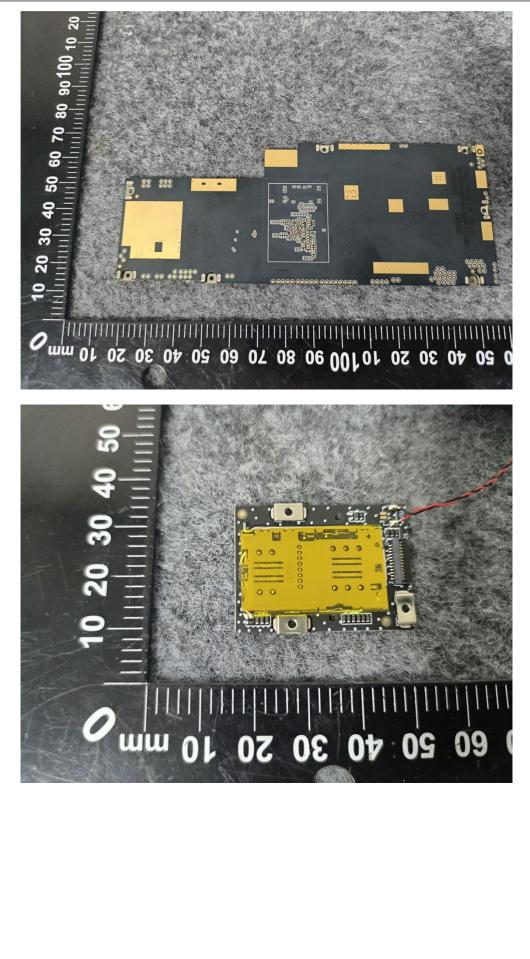




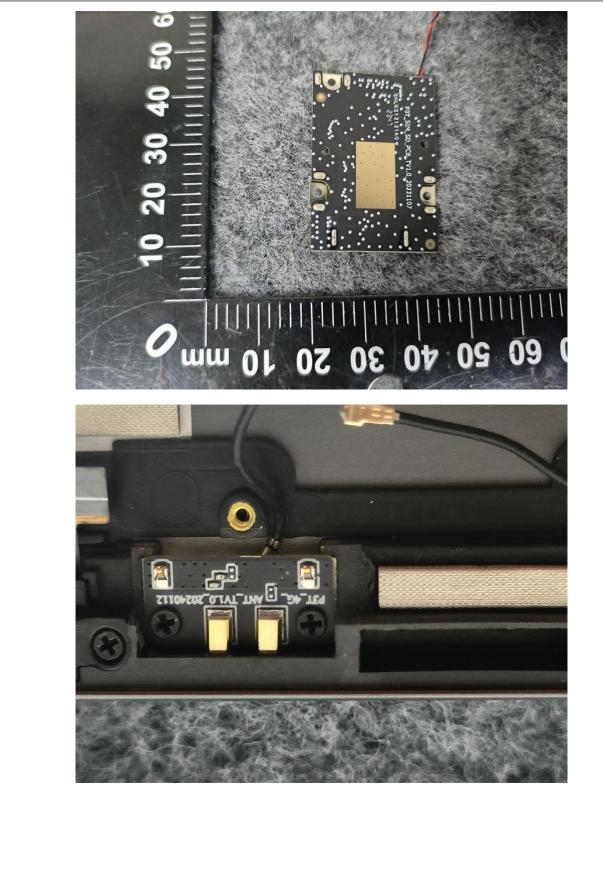




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